Search Notes

| Application/Control No. | Applicant(s)/Patent under Reexamination | |
|-------------------------|---|--|
| 09/896,163 | JERDONEK | |
| Examiner | Art Unit | |
| Flien C. Tran | 2134 | |

| | SEARCHED | | | | | |
|-------|----------|----------|----------|--|--|--|
| | | | | | | |
| Class | Subclass | Date | Examiner | | | |
| 713 | 153 | 5/4/2005 | ECT | | | |
| 713 | 200 | 5/4/2005 | ECT | | | |
| | | | | | | |
| | | | | | | |
| | | | | | | |
| | | | | | | |
| | | | | | | |
| | | | | | | |
| | | | | | | |
| | | | | | | |
| | | | | | | |
| | | | | | | |
| | | | | | | |
| | | | | | | |

| INT | INTERFERENCE SEARCHED | | | | |
|-------|-----------------------|------|----------|--|--|
| Class | Subclass | Date | Examiner | | |
| | | | | | |
| | | | | | |
| | | | | | |
| | | | | | |
| | | | | | |
| | | | | | |

| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | | | |
|---|----------|------|--|--|
| | DATE | EXMR | | |
| USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES | 5/4/2005 | ECT | | |
| | | | | |
| | | | | |
| | | | | |
| | | | | |
| | | | | |
| | | | | |
| | | | | |
| | | | | |